# UNISONIC TECHNOLOGIES CO., LTD

5N60-CQ **Preliminary Power MOSFET** 

# 5A, 600V N-CHANNEL **POWER MOSFET**

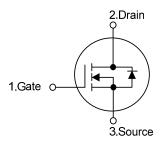
#### DESCRIPTION

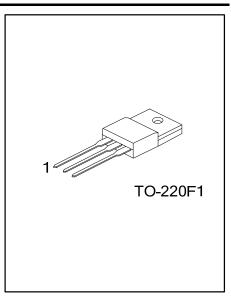
The UTC 5N60-CQ is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

#### **FEATURES**

- \*  $R_{DS(ON)}$  < 2.1  $\Omega$  @  $V_{GS}$  = 10 V,  $I_D$  = 2.5 A
- \* Fast switching capability
- \* Avalanche energy tested
- \* Improved dv/dt capability, high ruggedness

#### **SYMBOL**

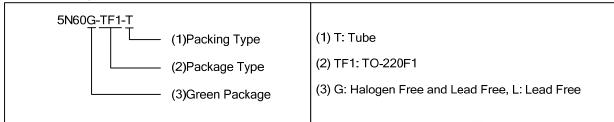




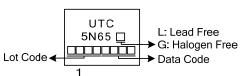
#### ORDERING INFORMATION

Ordering Number		Dealtons	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
5N60L-TF1-T	5N60G-TF1-T	TO-220F1	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



# **MARKING**



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# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	600	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Continuous Drain Current		$I_{D}$	5	Α	
Pulsed Drain Current (Note 2)		$I_{DM}$	20	Α	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	70	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.2	V/ns	
Power Dissipation		$P_{D}$	36	W	
Junction Temperature		$T_J$	+150	°C	
Storage Temperature		$T_{STG}$	-55 ~ <b>+</b> 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 16mH,  $I_{AS}$  = 2.96A,  $V_{DD}$  = 50V,  $R_G$  = 25  $\Omega$ , Starting  $T_J$  = 25°C
- 4.  $I_{SD} \le 5.0$ A, di/dt  $\le 200$ A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25$ °C

## ■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	$\theta_{JA}$	62.5	°C/W	
Junction to Case	$\theta_{JC}$	3.47	°C/W	

## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> =25°C, unless otherwise specified)

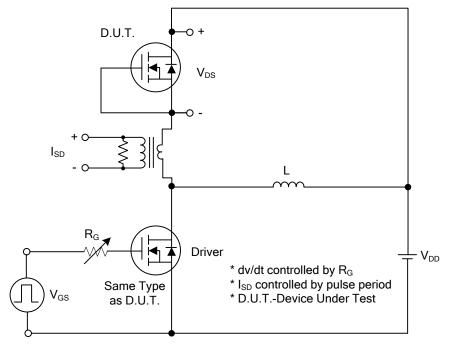
			<u> </u>				
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	600			V
Drain-Source Leakage Current		I <sub>DSS</sub>	$V_{DS} = 600V, V_{GS} = 0V$			10	μΑ
Cata Cauraa Laakaga Current	Forward		$V_{GS} = 30V, V_{DS} = 0V$			100	nA
Gate- Source Leakage Current	Reverse	$I_{GSS}$	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	$V_{GS} = 10V, I_D = 2.5A$			2.1	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance	nput Capacitance				532		pF
Output Capacitance		C <sub>ISS</sub>	V <sub>DS</sub> =25V, V <sub>GS</sub> =0V, f=1.0 MHz		77		pF
Reverse Transfer Capacitance		$C_{RSS}$			11		pF
SWITCHING CHARACTERISTICS	6						
Total Gate Charge (Note 1)		$Q_G$	\/ -F0\/ \/ -40\/   -4.24		50		nC
Gate-Source Charge		$Q_GS$	V <sub>DS</sub> =50V, V <sub>GS</sub> =10V, I <sub>D</sub> =1.3A, I <sub>D</sub> =100µA (Note 1, 2)		4.4		nC
Gate-Drain Charge		$Q_GD$	ID= 100μΑ (Note 1, 2)		8.6		nC
Turn-On Delay Time (Note 1)		$t_{D(ON)}$			46		ns
Turn-On Rise Time		t <sub>R</sub>	$V_{DD}$ =30V, $V_{GS}$ =10V, $I_{D}$ =0.5A,		60		ns
Turn-Off Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note 1, 2)		164		ns
Turn-Off Fall Time		t <sub>F</sub>			66		ns
DRAIN-SOURCE DIODE CHARAC	CTERISTIC	CS AND MA	XIMUM RATINGS				
Maximum Continuous Drain-Source Diode		Is	_ %	7		5	Α
Forward Current			2 112	0		Ü	A
Maximum Pulsed Drain-Source Diode		I <sub>SM</sub>	~ BR	),,		20	Α
Forward Current			1/19 280.			20	^
Drain-Source Diode Forward Voltage		$V_{\text{SD}}$	I <sub>S</sub> =5.0A , V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time		t <sub>rr</sub>	J <sub>S</sub> =5.0A , ∨ <sub>GS</sub> =0V		274		ns
Body Diode Reverse Recovery Charge		Q <sub>rit</sub>	di/dt=100A/µs		1.64		μC

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

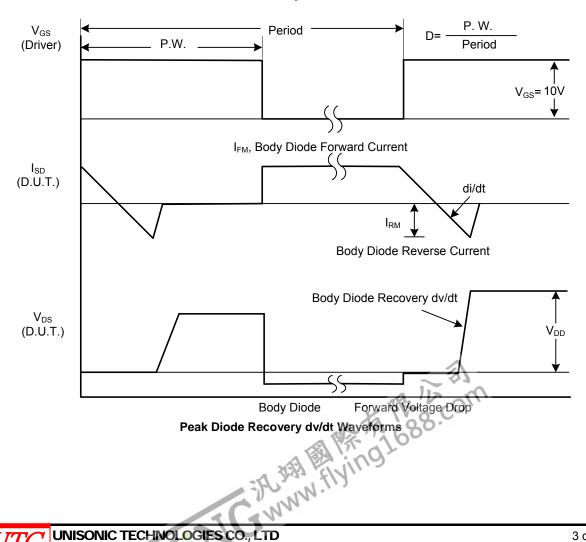
2. Essentially independent of operating temperature



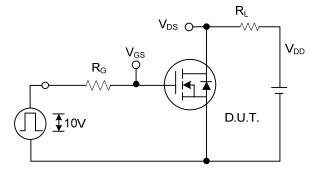
#### **TEST CIRCUITS AND WAVEFORMS**



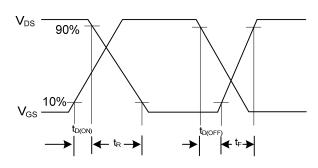
Peak Diode Recovery dv/dt Test Circuit



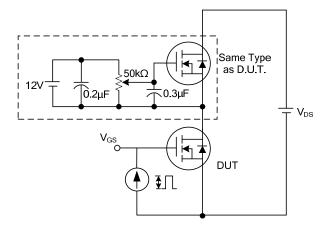
# ■ TEST CIRCUITS AND WAVEFORMS (Cont.)



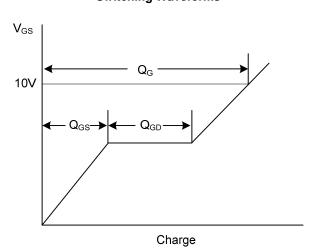
**Switching Test Circuit** 



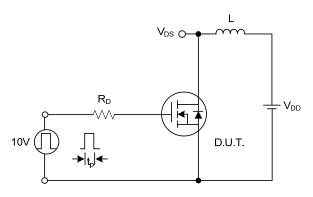
**Switching Waveforms** 



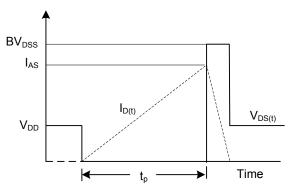
**Gate Charge Test Circuit** 



**Gate Charge Waveform** 



**Unclamped Inductive Switching Test Circuit** 



**Unclamped Inductive Switching Waveforms** 

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